



Low Cost, Precision JFET Input Operational Amplifier in TSOT

Preliminary Technical Data

ADA4000-1

FEATURES

- Very low offset voltage: 1 mV max
- Bias current: 10 pA max
- Small packaging, TSOT-23 lead-free
- ±5 V to ±15 V operation
- High slew rate: 20 V/μs
- Low voltage noise: 15 nV/√Hz
- Unity gain stable
- Wide bandwidth: 6 MHz

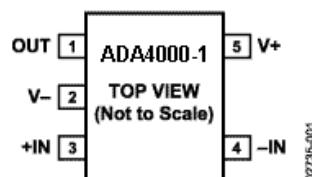
APPLICATIONS

- Reference gain/buffers
- Level shift/driving
- Active filters
- Power line monitoring/control
- Current/voltage sense or monitoring
- Data acquisition
- Sample-and-hold circuits
- Integrators

GENERAL DESCRIPTION

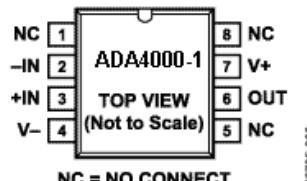
The AD4004 is a JFET input operational amplifier featuring precision, very low bias current, and low power in a tiny package at a very attractive price. Combining high input impedance, low input bias current, wide bandwidth, and fast slew rate, the AD4004 is an ideal amplifier for driving A/D inputs and buffering D/A converter outputs.

PIN CONFIGURATIONS



02/25/01

Figure 1. 5-Lead TSOT (UJ-5)



02/25/02

Figure 2. 8-Lead SOIC (R-8)

Additional applications for the AD4004 include electronic instruments; ATE amplification, buffering, and integrator circuits;

Instrumentation quality photodiode amplification; fast precision filters (including PLL filters), utility functions like reference buffering, level shifting, control I/O interface, power supply control and monitoring functions.

Rev. PrA

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REVISION HISTORY

10/05—Revision PrA: Preliminary Version

SPECIFICATIONS

ELECTRICAL SPECIFICATIONS

$V_S = \pm 5.0$ V, $V_{CM} = 0$ V, $T_A = +25^\circ\text{C}$, unless otherwise specified.

Table 1.

| Parameter | Symbol | Conditions | Min | Typ | Max | Units |
|------------------------------|--------------------------|--|-------|----------|-----|------------------------------|
| INPUT CHARACTERISTICS | | | | | | |
| Offset Voltage | V_{OS} | | 0.1 | 1.0 | | mV |
| Input Bias Current | I_B | | 5 | 10 | | pA |
| Input Offset Current | I_{OS} | $-40^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$ | | 5 | | pA |
| Input Voltage Range | | $-40^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$ | | | | pA |
| Common-Mode Rejection Ratio | CMRR | $-1.5 \text{ V} \leq V_{CM} \leq +3.5 \text{ V}$ $-40^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$ | -2.5 | 76 | 3.5 | V |
| Open Loop Gain (Note 1) | A_{VO} | $R_L = 2 \text{ k}\Omega, V_O = \pm 2.5 \text{ V}$ $-40^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$ | | 114 | | dB |
| Offset Voltage Drift | $\Delta V_{OS}/\Delta T$ | $-40^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$ | | 10 | | $\mu\text{V}/^\circ\text{C}$ |
| OUTPUT CHARACTERISTICS | | | | | | |
| Output Voltage High | V_{OH} | $R_L = 2 \text{ k}\Omega$ to ground $-40^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$ | 4.0 | | | V |
| Output Voltage Low | V_{OL} | $R_L = 2 \text{ k}\Omega$ to ground $-40^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$ | 3.7 | | | V |
| Short Circuit Limit | I_{SC} | | -3.35 | | | V |
| Output Current | I_O | $-40^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$ | -3.7 | | | V |
| | | $-40^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$ | 28 | | | mA |
| | | | | ± 10 | | mA |
| | | | | | | mA |
| POWER SUPPLY | | | | | | |
| Power Supply Rejection Ratio | PSRR | $V_S = \pm 5.0 \text{ V}$ to $\pm 15.0 \text{ V}$ $-40^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$ | 80 | | | dB |
| Supply Current/Amplifier | I_{SY} | $V_O = 0 \text{ V}$ $-40^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$ | 1.1 | | | mA |
| DYNAMIC PERFORMANCE | | | | | | mA |
| Slew Rate | SR | $V_i = 10 \text{ V}, R_L = 2 \text{ k}\Omega, C_L = 100 \text{ pF}$ | 20 | | | $\text{V}/\mu\text{s}$ |
| Gain Bandwidth Product | GBP | | 6 | | | MHz |
| NOISE PERFORMANCE | | | | | | |
| Voltage Noise | $e_{n,p-p}$ | 0.1 Hz to 10 Hz | 1.2 | | | $\mu\text{V}_p\text{-p}$ |
| Voltage Noise Density | e_n | $f = 1 \text{ kHz}$ | 15 | | | $\text{nV}/\sqrt{\text{Hz}}$ |
| Current Noise Density | i_n | $f = 1 \text{ kHz}$ | 0.01 | | | $\text{pA}/\sqrt{\text{Hz}}$ |

$V_S = \pm 15$ V, $V_{CM} = 0$ V, $T_A = +25^\circ\text{C}$, unless otherwise specified.

Table 2.

| Parameter | Symbol | Conditions | Min | Typ | Max | Units |
|------------------------------|--------------------------|--|------|----------|-------|------------------------------|
| INPUT CHARACTERISTICS | | | | | | |
| Offset Voltage | V_{OS} | | | 0.1 | 1.0 | mV |
| Input Bias Current | I_B | | 5 | 10 | | pA |
| Input Offset Current | I_{OS} | $-40^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$ | 5 | 5 | | pA |
| Input Voltage Range | | $-40^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$ | | | | pA |
| Common-Mode Rejection Ratio | CMRR | $-11 \text{ V} \leq V_{CM} \leq +15 \text{ V}$ $-40^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$ | -11 | 80 | +15 | dB |
| Open Loop Gain | A_{VO} | $R_L = 2\text{k}\Omega$, $V_O = \pm 10\text{V}$ $-40^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$ | | 114 | | dB |
| Offset Voltage Drift | $\Delta V_{OS}/\Delta T$ | $-40^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$ | | 10 | | $\mu\text{V}/^\circ\text{C}$ |
| OUTPUT CHARACTERISTICS | | | | | | |
| Output Voltage High | V_{OH} | $R_L = 2\text{k}\Omega$ to ground $-40^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$ | 13.7 | | | V |
| Output Voltage Low | V_{OL} | $R_L = 2\text{k}\Omega$ to ground $-40^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$ | 13.5 | -13.3 | -13.5 | V |
| Short Circuit Limit | I_{SC} | | | 28 | | mA |
| Output Current | I_O | $-40^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$ $-40^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$ | | ± 10 | | mA |
| POWER SUPPLY | | | | | | |
| Power Supply Rejection Ratio | PSRR | $V_S = \pm 4.0 \text{ V}$ to $\pm 18.0 \text{ V}$ $-40^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$ | 80 | | | dB |
| Supply Current/Amplifier | I_{SY} | $-40^\circ\text{C} \leq T_A \leq +125^\circ\text{C}$ | | 1.2 | | mA |
| DYNAMIC PERFORMANCE | | | | | | |
| Slew Rate | SR | $V_i = 10 \text{ V}$, $R_L = 2\text{k}\Omega$, $C_L = 100 \text{ pF}$ | 20 | | | $\text{V}/\mu\text{s}$ |
| Gain Bandwidth Product | GBP | | 6 | | | MHz |
| NOISE PERFORMANCE | | | | | | |
| Voltage Noise | $e_{n,p-p}$ | 0.1 to 10 Hz | | 1.2 | | μV_p-p |
| Voltage Noise Density | e_n | $f = 1 \text{ kHz}$ | | 15 | | $\text{nV}/\sqrt{\text{Hz}}$ |
| Current Noise Density | i_n | $f = 1 \text{ kHz}$ | | 0.01 | | $\text{pA}/\sqrt{\text{Hz}}$ |

ABSOLUTE MAXIMUM RATINGS

Table 3.

| Parameter | Rating |
|--|---|
| Supply Voltage | $\pm 18\text{ V}/+36\text{ V}$ |
| Input Voltage | $\pm \text{V supply}$ |
| Differential Input Voltage ¹ | $\pm \text{V supply}$ |
| Output Short-Circuit Duration to Gnd | Indefinite |
| Storage Temperature Range UJZ, RZ Packages | -65°C to $+150^\circ\text{C}$ |
| Operating Temperature Range ADA4000-1 | -40°C to $+125^\circ\text{C}$ |
| Junction Temperature Range UJZ, RZ Packages | -65°C to $+150^\circ\text{C}$ |
| Lead Temperature (Soldering, 10 sec) | $+300^\circ\text{C}$ |

¹ Differential input voltage is limited to ± 5.0 volts or the supply voltage, whichever is less.

Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those indicated in the operational section of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

THERMAL RESISTANCE

θ_{JA} is specified for the worst-case conditions, that is, for a device in socket for PDIP packages; a device soldered in a circuit board for SOIC and TSSOP packages.

Table 4. Thermal Resistance

| Package Type | θ_{JA} | θ_{JC} | Unit |
|------------------|---------------|---------------|--------------------|
| 5-Pin TSOT (UJZ) | | | $^\circ\text{C/W}$ |
| 8-Pin SOIC (RZ) | 158 | 43 | $^\circ\text{C/W}$ |

ORDERING GUIDE

| Model | Temperature Range | Package Description | Package Option |
|----------------------------|-------------------|---------------------|----------------|
| ADA4000-1AUJZ ¹ | −40°C to +125°C | 5-Pin TSOT | UJZ-5 |
| ADA4000-1ARZ ¹ | −40°C to +125°C | 8-Pin SOIC | RZ-8 |

¹ Z = Pb-free part.

NOTES

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